Notice of References Cited

Application/Control No. 10/650,238	Applicant(s)/Pater Reexamination SCHULTE ET AL	ion		
Examiner	Art Unit			
TUAN A. VU	2193	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,704,804	03-2004	Wilson et al.	719/315
*	В	US-6,983,448	01-2006	Hartel et al.	717/116
*	С	US-2005/0114771	05-2005	Piehler et al.	715/536
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	-
	Н	US-		-	
	1	US-		-	
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	Total of Tot					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		l			
	Q		l			
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

		NON-FATENT DOCUMENTS		
*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	"Class Introspector", Java 2 Platform, Sun Microsystems ed. ver. 1.4.0, Copyright 1993-2002 pp. 1-6		
	v			
	w			
	х			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.